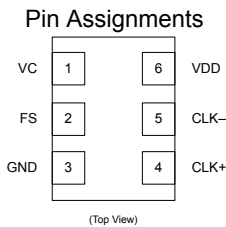




Ultra Series™ Crystal Oscillator (VCXO) Si566 Data Sheet

Ultra Low Jitter Dual Any-Frequency VCXO (100 fs), 0.2 to 3000 MHz

The Si566 Ultra Series™ voltage-controlled crystal oscillator utilizes Silicon Laboratories' advanced 4th generation DSPLL® technology to provide an ultra-low jitter, low phase noise clock at two selectable frequencies. The device is factory-programmed to provide any two selectable frequencies from 0.2 to 3000 MHz with <1 ppb resolution and maintains exceptionally low jitter for both integer and fractional frequencies across its operating range. On-chip power supply filtering provides industry-leading power supply noise rejection, simplifying the task of generating low jitter clocks in noisy systems that use switched-mode power supplies. Offered in industry-standard 3.2x5 mm and 5x7 mm footprints, the Si566 has a dramatically simplified supply chain that enables Silicon Labs to ship custom frequency samples 1-2 weeks after receipt of order. Unlike a traditional XO, where a different crystal is required for each output frequency, the Si566 uses one simple crystal and a DSPLL IC-based approach to provide the desired output frequencies. The Si566 is factory-configurable for a wide variety of user specifications, including frequency, output format, and OE pin location/polarity. Specific configurations are factory-programmed at time of shipment, eliminating the long lead times associated with custom oscillators.



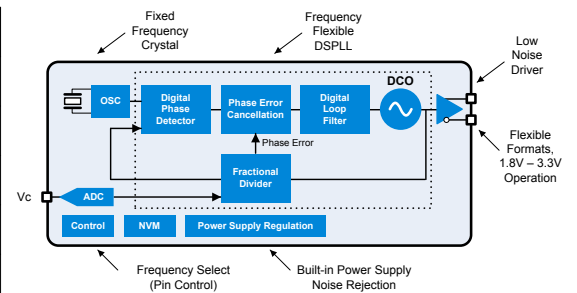
| Pin # | Descriptions |
|-------|---|
| 1 | VC = Voltage Control Pin |
| 2 | FS = Frequency Select |
| 3 | GND = Ground |
| 4 | CLK+ = Clock output |
| 5 | CLK- = Complementary clock output. Not used for CMOS. |
| 6 | VDD = Power supply |

KEY FEATURES

- Available with any two selectable frequencies from 200 kHz to 3000 MHz
- Ultra low jitter: 100 fs RMS typical (12 kHz – 20 MHz)
- Excellent PSRR and supply noise immunity: –80 dBc Typ
- 3.3 V, 2.5 V and 1.8 V V_{DD} supply operation from the same part number
- LVPECL, LVDS, CML, HCSL, CMOS, and Dual CMOS output options
- 3.2x5, 5x7 mm package footprints
- Samples available with 1-2 week lead times

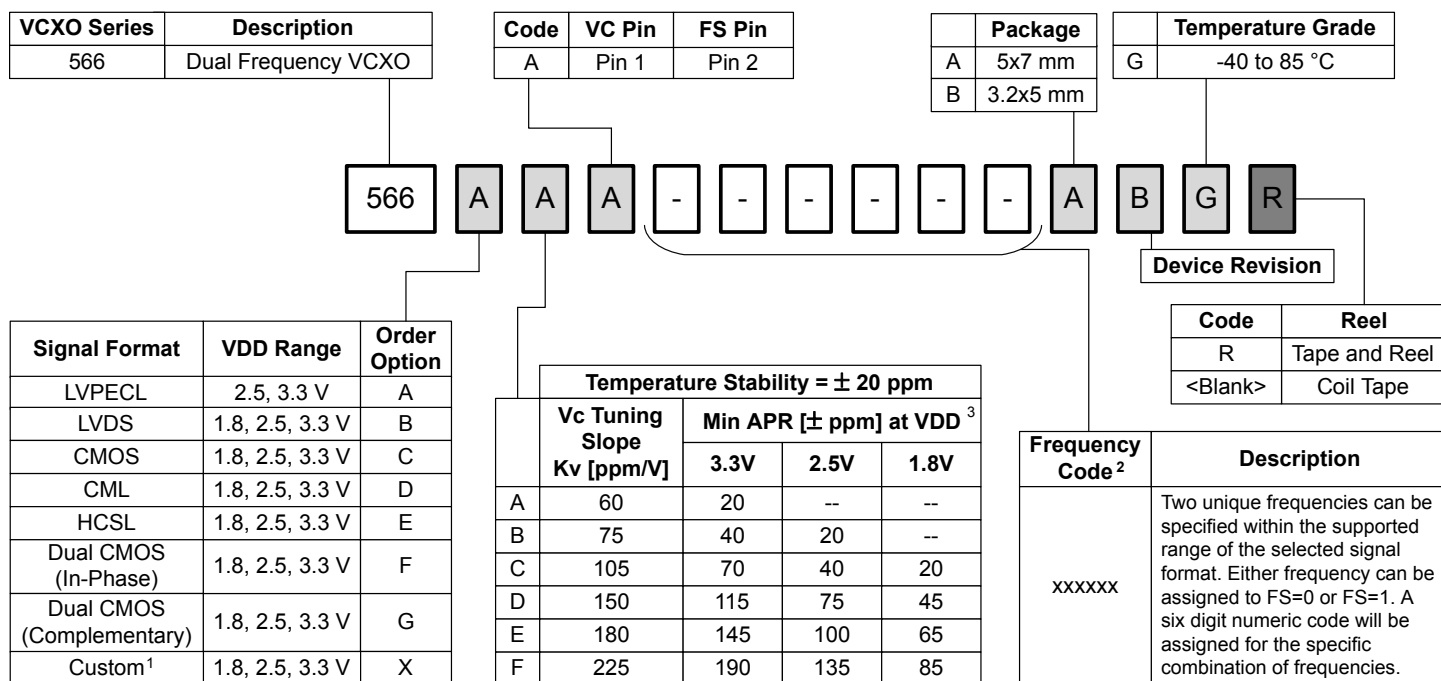
APPLICATIONS

- 100G/200G/400G OTN, coherent optics
- 10G/25G/40G/100G Ethernet
- 56G/112G PAM4 clocking
- 3G-SDI/12G-SDI/24G-SDI broadcast video
- Servers, switches, storage, NICs, search acceleration
- Test and measurement
- FPGA/ASIC clocking



1. Ordering Guide

The Si566 VCXO supports a variety of options including frequency, output format, and OE pin location/polarity, as shown in the chart below. Specific device configurations are programmed into the part at time of shipment, and samples are available in 1-2 weeks. Silicon Laboratories provides an online part number configuration utility to simplify this process. Refer to www.silabs.com/oscillators to access this tool and for further ordering instructions.



Notes:

- Contact Silicon Labs for non-standard configurations.
- Create custom part numbers at www.silabs.com/oscillators.
- Min Absolute Pull Range (APR) includes temp stability, initial accuracy, load pulling, VDD variation, and 20 year aging at 70 °C.
 - For best jitter and phase noise performance, always choose the smallest Kv that meets the application's minimum APR requirements. Unlike SAW-based solutions which require higher Kv values to account for their higher temperature dependence, the Si56x series provides lower Kv options to minimize noise coupling and jitter in real-world PLL designs.
 - APR is the ability of a VCXO to track a signal over the product lifetime. A VCXO with an APR of ±20 ppm is able to lock to a clock with a ±20 ppm stability over 20 years over all operating conditions.
 - $APR (\pm) = (0.5 \times VDD \times \text{tuning slope}) - (\text{initial accuracy} + \text{temp stability} + \text{load pulling} + \text{VDD variation} + \text{aging})$.
 - Minimum APR values noted above include absolute worst case values for all parameters.
 - See application note, "AN266: VCXO Tuning Slope (Kv), Stability, and Absolute Pull Range (APR)" for more information.

1.1 Technical Support

| | |
|---------------------------------------|--|
| Frequently Asked Questions (FAQ) | www.silabs.com/Si566-FAQ |
| Oscillator Phase Noise Lookup Utility | www.silabs.com/oscillator-phase-noise-lookup |
| Quality and Reliability | www.silabs.com/quality |
| Development Kits | www.silabs.com/oscillator-tools |

2. Electrical Specifications

Table 2.1. Electrical Specifications
 $V_{DD} = 1.8\text{ V}, 2.5\text{ or }3.3\text{ V} \pm 5\%$, $T_A = -40\text{ to }85\text{ }^\circ\text{C}$

| Parameter | Symbol | Test Condition/Comment | Min | Typ | Max | Unit |
|--|-----------|--|---------------------|------|---------------------|------------------|
| Temperature Range | T_A | | -40 | — | 85 | $^\circ\text{C}$ |
| Frequency Range | F_{CLK} | LVPECL, LVDS, CML | 0.2 | — | 3000 | MHz |
| | | HCSL | 0.2 | — | 400 | MHz |
| | | CMOS, Dual CMOS | 0.2 | — | 250 | MHz |
| Supply Voltage | V_{DD} | 3.3 V | 3.135 | 3.3 | 3.465 | V |
| | | 2.5 V | 2.375 | 2.5 | 2.625 | V |
| | | 1.8 V | 1.71 | 1.8 | 1.89 | V |
| Supply Current | I_{DD} | LVPECL (output enabled) | — | 120 | 170 | mA |
| | | LVDS/CML (output enabled) | — | 100 | 167 | mA |
| | | HCSL (output enabled) | — | 95 | 140 | mA |
| | | CMOS (output enabled) | — | 95 | 145 | mA |
| | | Dual CMOS (output enabled) | — | 105 | 155 | mA |
| | | Tristate Hi-Z (output disabled) | — | 83 | — | mA |
| Temperature Stability ¹ | | -40 to 85 $^\circ\text{C}$ | -20 | — | 20 | ppm |
| Rise/Fall Time (20% to 80% V_{PP}) | T_R/T_F | LVPECL/LVDS/CML | — | — | 350 | ps |
| | | CMOS / Dual CMOS ($C_L = 5\text{ pF}$) | — | 0.5 | 1.5 | ns |
| | | HCSL, $F_{CLK} > 50\text{ MHz}$ | — | — | 550 | ps |
| Duty Cycle | D_C | All formats | 45 | — | 55 | % |
| Frequency Select (FS) ² | V_{IH} | | $0.7 \times V_{DD}$ | — | — | V |
| | V_{IL} | | — | — | $0.3 \times V_{DD}$ | V |
| | T_{FS} | Settling Time after FS Change | — | — | 10 | ms |
| Powerup Time | t_{OSC} | Time from $0.9 \times V_{DD}$ until output frequency (F_{CLK}) within spec | — | — | 10 | ms |
| LVPECL Output Option ³ | V_{OC} | Mid-level | $V_{DD} - 1.42$ | — | $V_{DD} - 1.25$ | V |
| | V_O | Swing (diff, $F_{CLK} \leq 1.5\text{ GHz}$) | 1.1 | — | 1.9 | V_{PP} |
| | | Swing (diff, $F_{CLK} > 1.5\text{ GHz}$) ⁶ | 0.55 | — | 1.7 | V_{PP} |
| LVDS Output Option ⁴ | V_{OC} | Mid-level (2.5 V, 3.3 V V_{DD}) | 1.125 | 1.20 | 1.275 | V |
| | | Mid-level (1.8 V V_{DD}) | 0.8 | 0.9 | 1.0 | V |
| | V_O | Swing (diff, $F_{CLK} \leq 1.5\text{ GHz}$) | 0.5 | 0.7 | 0.9 | V_{PP} |
| | | Swing (diff, $F_{CLK} > 1.5\text{ GHz}$) ⁶ | 0.25 | 0.5 | 0.8 | V_{PP} |

| Parameter | Symbol | Test Condition/Comment | Min | Typ | Max | Unit |
|---------------------------------|----------|--|----------------------|------|----------------------|----------|
| HCSL Output Option ⁵ | V_{OH} | Output voltage high | 660 | 800 | 850 | mV |
| | V_{OL} | Output voltage low | -150 | 0 | 150 | mV |
| | V_C | Crossing voltage | 250 | 410 | 550 | mV |
| CML Output Option (AC-Coupled) | V_O | Swing (diff, $F_{CLK} \leq 1.5$ GHz) | 0.6 | 0.8 | 1.0 | V_{PP} |
| | | Swing (diff, $F_{CLK} > 1.5$ GHz) ⁶ | 0.3 | 0.55 | 0.9 | V_{PP} |
| CMOS Output Option | V_{OH} | $I_{OH} = 8/6/4$ mA for 3.3/2.5/1.8 V VDD | $0.85 \times V_{DD}$ | — | — | V |
| | V_{OL} | $I_{OL} = 8/6/4$ mA for 3.3/2.5/1.8 V VDD | — | — | $0.15 \times V_{DD}$ | V |

Notes:

1. Min APR includes temperature stability, initial accuracy, load pulling, VDD variation, and aging for 20 yrs at 70 °C.
2. FS pin includes a 50 k Ω pull-up to VDD.
3. $R_{term} = 50 \Omega$ to $V_{DD} - 2.0$ V (see Figure 4.1).
4. $R_{term} = 100 \Omega$ (differential) (see Figure 4.2).
5. $R_{term} = 50 \Omega$ to GND (see Figure 4.2).
6. Refer to the figure below for Typical Clock Output Swing Amplitudes vs Frequency.

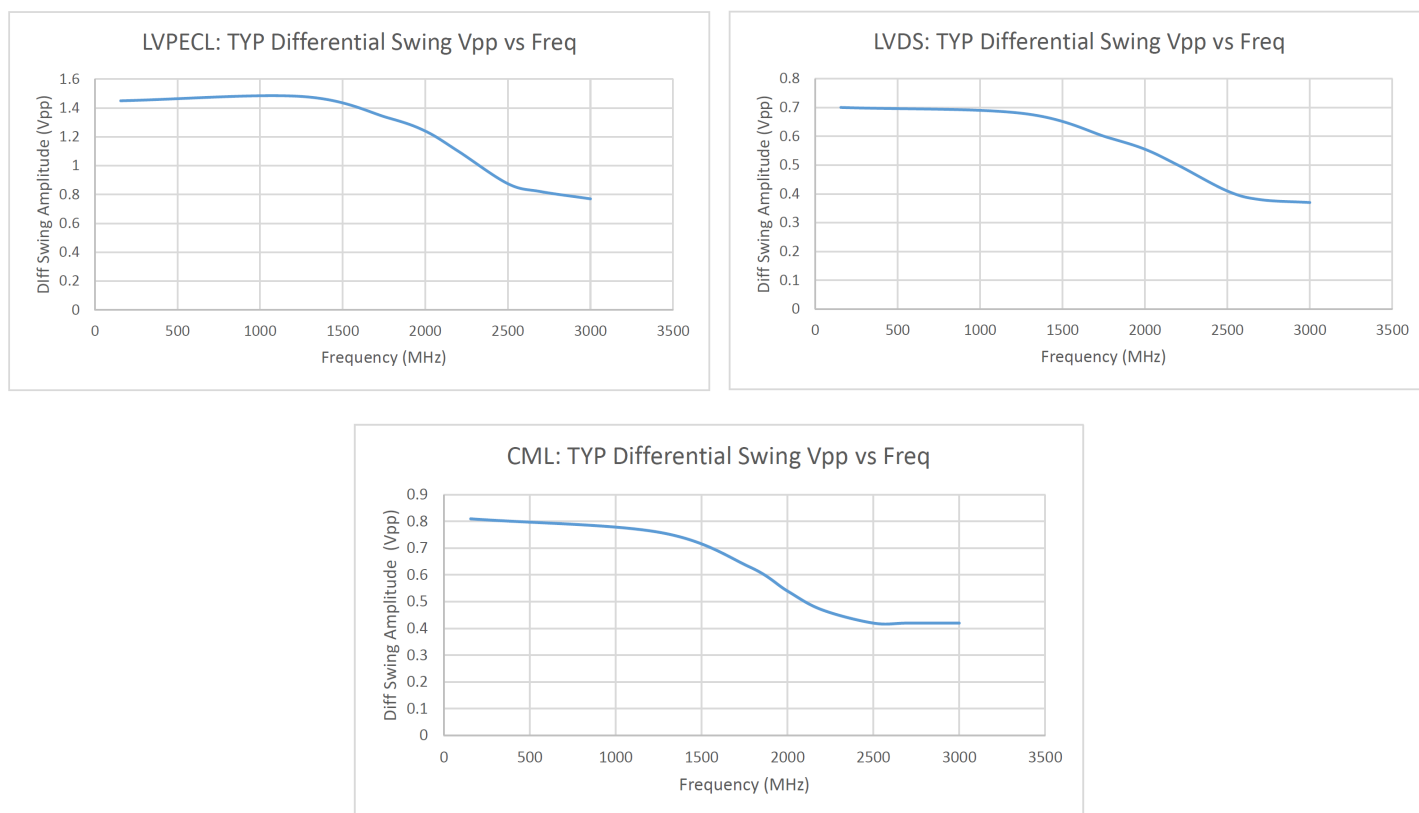
**Figure 2.1. Typical Clock Output Swing Amplitudes vs. Frequency**

Table 2.2. V_C Control Voltage InputV_{DD} = 1.8, 2.5 or 3.3 V ± 5%, T_A = -40 to 85 °C

| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
|---|----------------|---------------------------------|----------------------------|-------|-----------|-------|
| Control Voltage Range | V _C | | 0.1 x VDD | VDD/2 | 0.9 x VDD | V |
| Control Voltage Tuning Slope (V _c = 10% VDD to 90% VDD) | Kv | Positive slope, ordering option | 60, 75, 105, 150, 180, 225 | | | ppm/V |
| Kv Variation | Kv_var | | — | — | ±10 | % |
| Control Voltage Linearity | LVC | Best Straight Line fit | -1.5 | ±0.5 | +1.5 | % |
| Modulation Bandwidth | BW | | — | 10 | — | kHz |
| Vc Input Impedance | ZVC | | 500 | — | — | kΩ |

Table 2.3. Clock Output Phase Jitter and PSRRV_{DD} = 1.8 V, 2.5 or 3.3 V ± 5%, T_A = -40 to 85 °C

| Parameter | Symbol | Test Condition/Comment | Min | Typ | Max | Unit |
|--|----------------|-------------------------------------|-----|-----|-----|------|
| Phase Jitter (RMS, 12 kHz - 20 MHz) ¹ All Differential Formats, F _{CLK} ≥ 200 MHz | ϕ _J | Kv = 60 ppm/V | — | 100 | 150 | fs |
| | | Kv = 75 ppm/V | — | 103 | — | fs |
| | | Kv = 105 ppm/V | — | 110 | — | fs |
| | | Kv = 150 ppm/V | — | 123 | — | fs |
| | | Kv = 180 ppm/V | — | 132 | — | fs |
| | | Kv = 225 ppm/V | — | 150 | — | fs |
| Phase Jitter (RMS, 12 kHz - 20 MHz) ¹ All Diff Formats, 100 MHz ≤ F _{CLK} < 200 MHz | ϕ _J | Kv = 60 ppm/V | — | 115 | 170 | fs |
| | | Kv = 75 ppm/V | — | 118 | — | fs |
| | | Kv = 105 ppm/V | — | 125 | — | fs |
| | | Kv = 150 ppm/V | — | 138 | — | fs |
| | | Kv = 180 ppm/V | — | 147 | — | fs |
| | | Kv = 225 ppm/V | — | 165 | — | fs |
| Phase Jitter (RMS, 12 kHz - 20 MHz) ¹ LVDS, F _{CLK} = 156.25 MHz | ϕ _J | Kv = 60 ppm/V | — | 110 | 130 | fs |
| | | Kv = 75 ppm/V | — | 113 | — | fs |
| | | Kv = 105 ppm/V | — | 120 | — | fs |
| | | Kv = 150 ppm/V | — | 133 | — | fs |
| | | Kv = 180 ppm/V | — | 142 | — | fs |
| | | Kv = 225 ppm/V | — | 160 | — | fs |
| Phase Jitter (RMS, 12 kHz - 20 MHz) ¹ CMOS / Dual CMOS Formats | ϕ _J | 10 MHz ≤ F _{CLK} < 250 MHz | — | 200 | — | fs |

| Parameter | Symbol | Test Condition/Comment | Min | Typ | Max | Unit |
|--|--------|------------------------|-----|-----|-----|------|
| Spurs Induced by External Power Supply Noise, 50 mVpp Ripple. LVDS 156.25 MHz Output | PSRR | 100 kHz sine wave | | -83 | | dBc |
| | | 200 kHz sine wave | | -83 | | |
| | | 500 kHz sine wave | | -82 | | |
| | | 1 MHz sine wave | | -85 | | |

Note:

1. Jitter inclusive of any spurs.

Table 2.4. 3.2 x 5 mm Clock Output Phase Noise (Typical)

| Offset Frequency (f) | 156.25 MHz LVDS | 200 MHz LVDS | 644.53125 MHz LVDS | Unit |
|----------------------|-------------------|----------------|----------------------|--------|
| 100 Hz | -73 | -71 | -60 | dBc/Hz |
| 1 kHz | -102 | -102 | -93 | |
| 10 kHz | -130 | -128 | -118 | |
| 100 kHz | -141 | -139 | -129 | |
| 1 MHz | -150 | -148 | -138 | |
| 10 MHz | -159 | -160 | -153 | |
| 20 MHz | -160 | -162 | -154 | |
| Offset Frequency (f) | 156.25 MHz LVPECL | 200 MHz LVPECL | 644.53125 MHz LVPECL | Unit |
| 100 Hz | -72 | -71 | -60 | dBc/Hz |
| 1 kHz | -103 | -101 | -92 | |
| 10 kHz | -130 | -127 | -117 | |
| 100 kHz | -142 | -139 | -129 | |
| 1 MHz | -150 | -148 | -138 | |
| 10 MHz | -160 | -162 | -154 | |
| 20 MHz | -161 | -162 | -156 | |

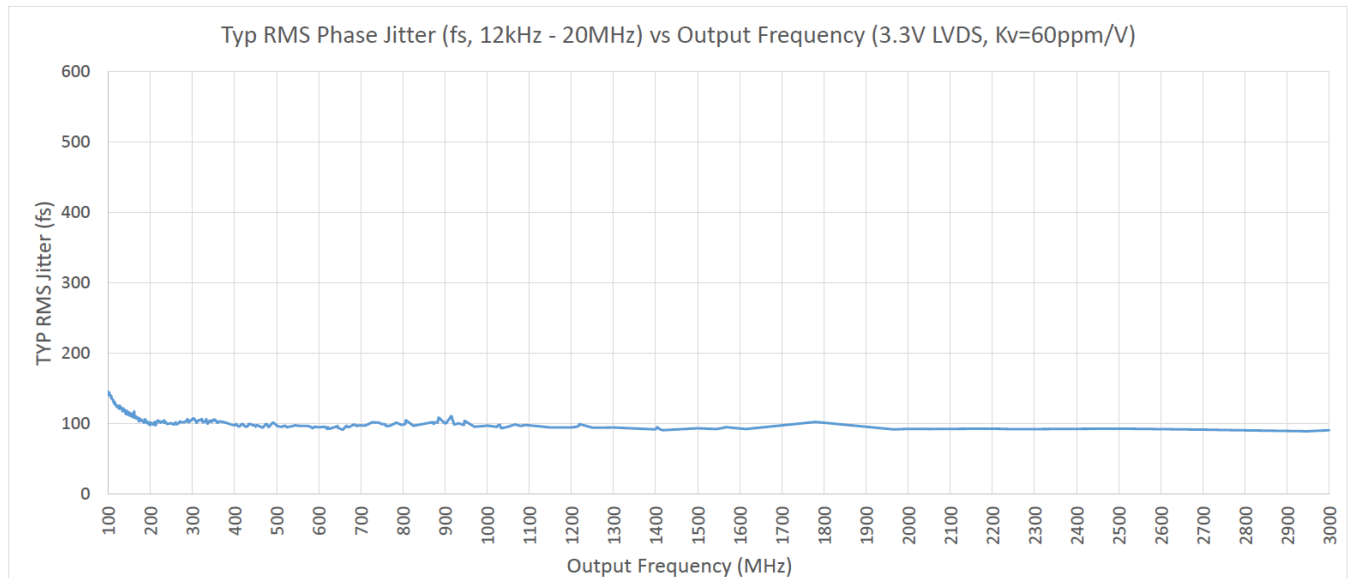


Figure 2.2. Phase Jitter vs. Output Frequency

Phase jitter measured with Agilent E5052 using a differential-to-single ended converter (balun or buffer). Measurements collected for >700 commonly used frequencies. Phase noise plots for specific frequencies are available using our free, online Oscillator Phase Noise Lookup Tool at www.silabs.com/oscillators.

Table 2.5. Environmental Compliance and Package Information

| Parameter | Test Condition |
|----------------------------------|--------------------------|
| Mechanical Shock | MIL-STD-883, Method 2002 |
| Mechanical Vibration | MIL-STD-883, Method 2007 |
| Solderability | MIL-STD-883, Method 2003 |
| Gross and Fine Leak | MIL-STD-883, Method 1014 |
| Resistance to Solder Heat | MIL-STD-883, Method 2036 |
| Moisture Sensitivity Level (MSL) | 1 |
| Contact Pads | Gold over Nickel |

Note:

- For additional product information not listed in the data sheet (e.g. RoHS Certifications, MDDS data, qualification data, REACH Declarations, ECCN codes, etc.), refer to our "Corporate Request For Information" portal found here: www.silabs.com/support/quality/Pages/RoHSInformation.aspx.

Table 2.6. Thermal Conditions

| Package | Parameter | Symbol | Test Condition | Value | Unit |
|--------------------------|--|---------------|------------------|-------|------|
| 3.2 × 5 mm 6-pin CLCC | Thermal Resistance Junction to Ambient | Θ_{JA} | Still Air, 85 °C | 80.3 | °C/W |
| | Thermal Resistance Junction to Board | Θ_{JB} | Still Air, 85 °C | 50.8 | °C/W |
| | Max Junction Temperature | T_J | Still Air, 85 °C | 125 | °C |
| 5 × 7 mm 6-pin CLCC | Thermal Resistance Junction to Ambient | Θ_{JA} | Still Air, 85 °C | 68.4 | °C/W |
| | Thermal Resistance Junction to Board | Θ_{JB} | Still Air, 85 °C | 52.9 | °C/W |
| | Max Junction Temperature | T_J | Still Air, 85 °C | 125 | °C |

Table 2.7. Absolute Maximum Ratings¹

| Parameter | Symbol | Rating | Unit |
|--|------------|------------------------|------|
| Maximum Operating Temp. | T_{AMAX} | 95 | °C |
| Storage Temperature | T_S | -55 to 125 | °C |
| Supply Voltage | V_{DD} | -0.5 to 3.8 | °C |
| Input Voltage | V_{IN} | -0.5 to $V_{DD} + 0.3$ | V |
| ESD HBM (JESD22-A114) | HBM | 2.0 | kV |
| Solder Temperature ² | T_{PEAK} | 260 | °C |
| Solder Time at T_{PEAK} ² | T_P | 20–40 | sec |

Notes:

- Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.
- The device is compliant with JEDEC J-STD-020.

3. Dual CMOS Buffer

Dual CMOS output format ordering options support either complementary or in-phase signals for two identical frequency outputs. This feature enables replacement of multiple VCXOs with a single Si566 device.



Figure 3.1. Integrated 1:2 CMOS Buffer Supports Complementary or In-Phase Outputs

4. Recommended Output Terminations

The output drivers support both AC-coupled and DC-coupled terminations as shown in figures below.

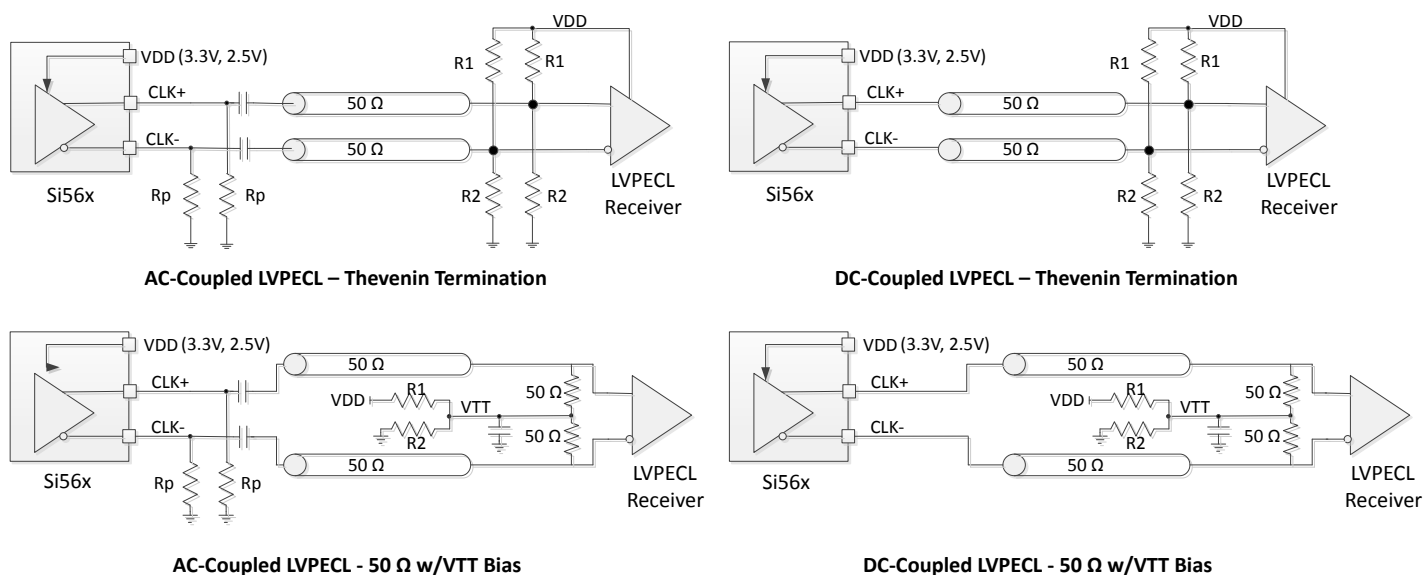


Figure 4.1. LVPECL Output Terminations

| AC-Coupled LVPECL Termination Resistor Values | | | | DC-Coupled LVPECL Termination Resistor Values | | |
|---|-------|--------|-------|---|-------|--------|
| VDD | R1 | R2 | Rp | VDD | R1 | R2 |
| 3.3 V | 127 Ω | 82.5 Ω | 130 Ω | 3.3 V | 127 Ω | 82.5 Ω |
| 2.5 V | 250 Ω | 62.5 Ω | 90 Ω | 2.5 V | 250 Ω | 62.5 Ω |

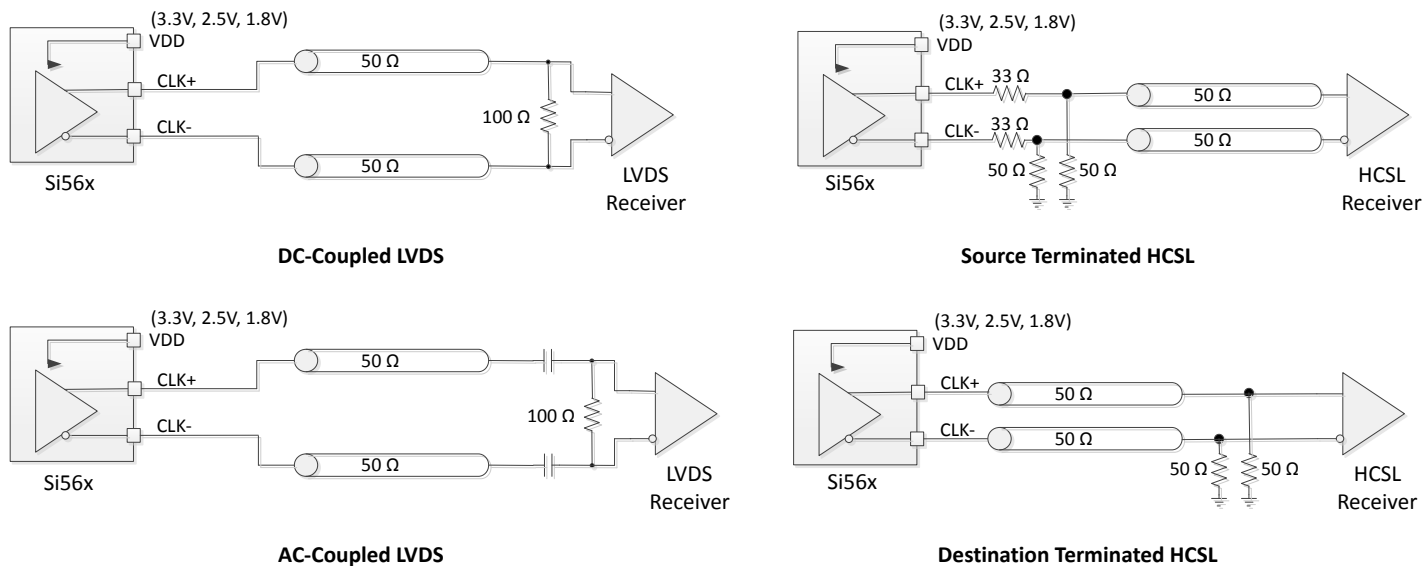


Figure 4.2. LVDS and HCSL Output Terminations

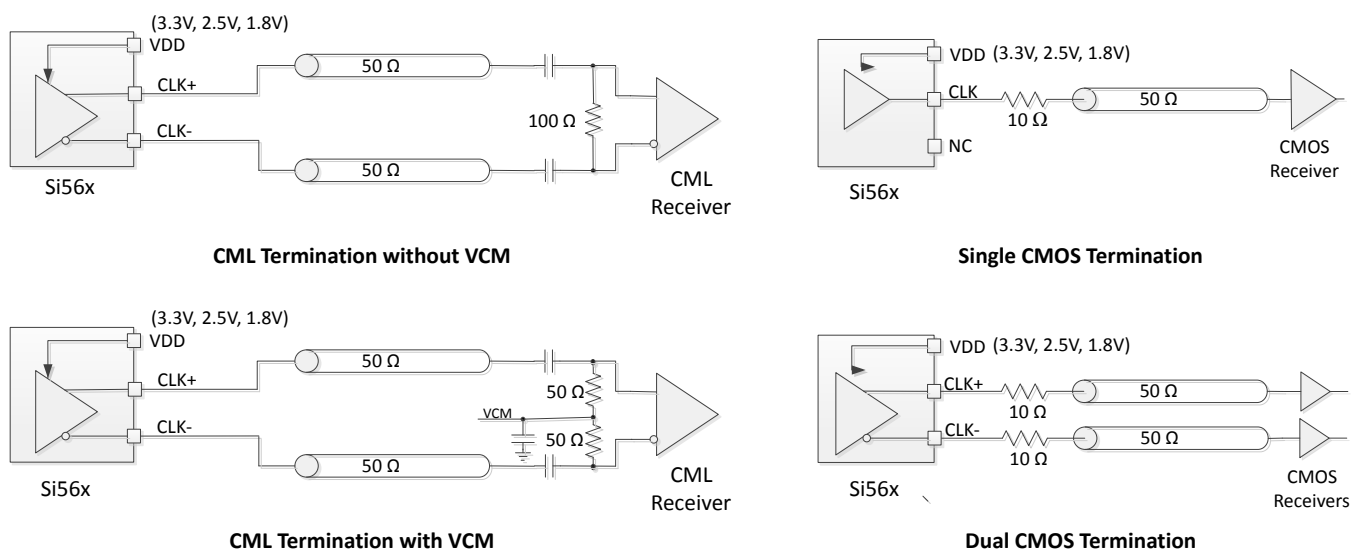


Figure 4.3. CML and CMOS Output Terminations

5. Package Outline

5.1 Package Outline (5×7 mm)

The figure below illustrates the package details for the 5×7 mm Si566. The table below lists the values for the dimensions shown in the illustration.

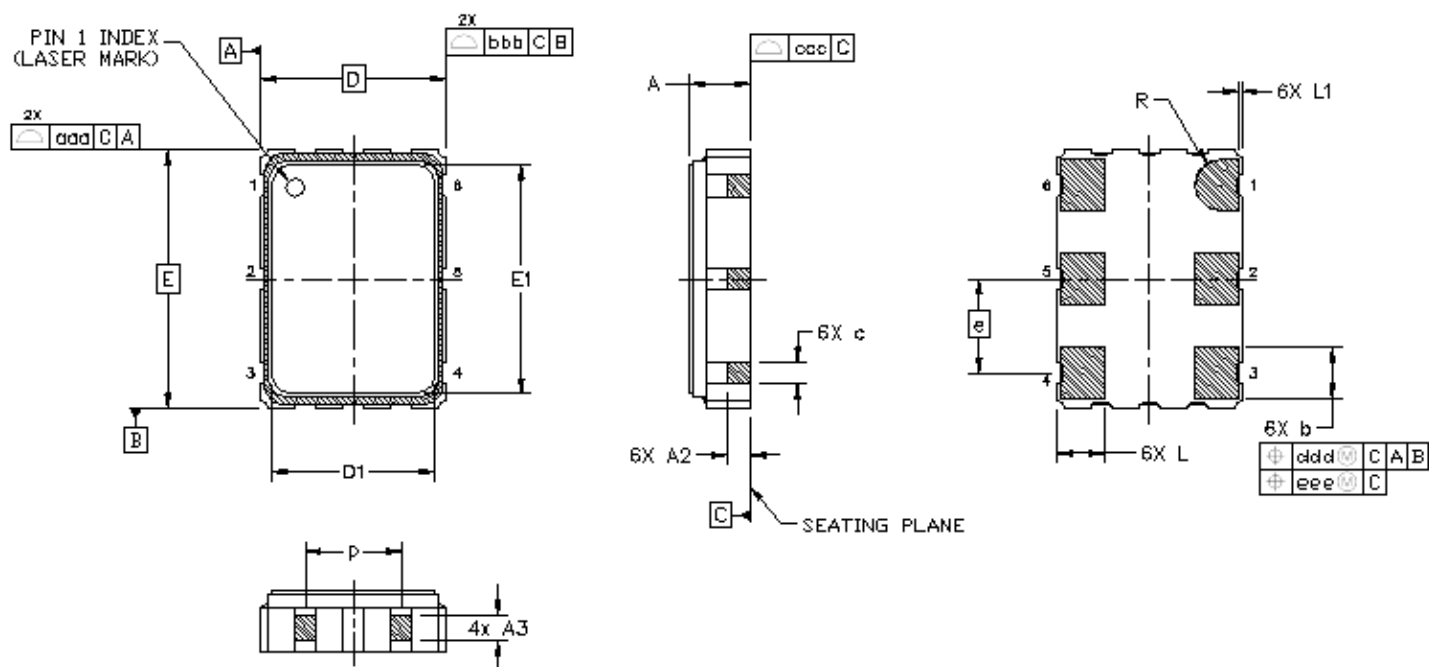


Figure 5.1. Si566 (5×7 mm) Outline Diagram

Table 5.1. Package Diagram Dimensions (mm)

| Dimension | Min | Nom | Max | Dimension | Min | Nom | Max |
|-----------|----------|------|------|-----------|----------|------|------|
| A | 1.13 | 1.28 | 1.43 | L | 1.17 | 1.27 | 1.37 |
| A2 | 0.50 | 0.55 | 0.60 | L1 | 0.05 | 0.10 | 0.15 |
| A3 | 0.50 | 0.55 | 0.60 | p | 1.70 | — | 1.90 |
| b | 1.30 | 1.40 | 1.50 | R | 0.70 REF | | |
| c | 0.50 | 0.60 | 0.70 | aaa | 0.15 | | |
| D | 5.00 BSC | | | bbb | 0.15 | | |
| D1 | 4.30 | 4.40 | 4.50 | ccc | 0.08 | | |
| e | 2.54 BSC | | | ddd | 0.10 | | |
| E | 7.00 BSC | | | eee | 0.05 | | |
| E1 | 6.10 | 6.20 | 6.30 | | | | |

Notes:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

5.2 Package Outline (3.2×5 mm)

The figure below illustrates the package details for the 3.2×5 mm Si566. The table below lists the values for the dimensions shown in the illustration.

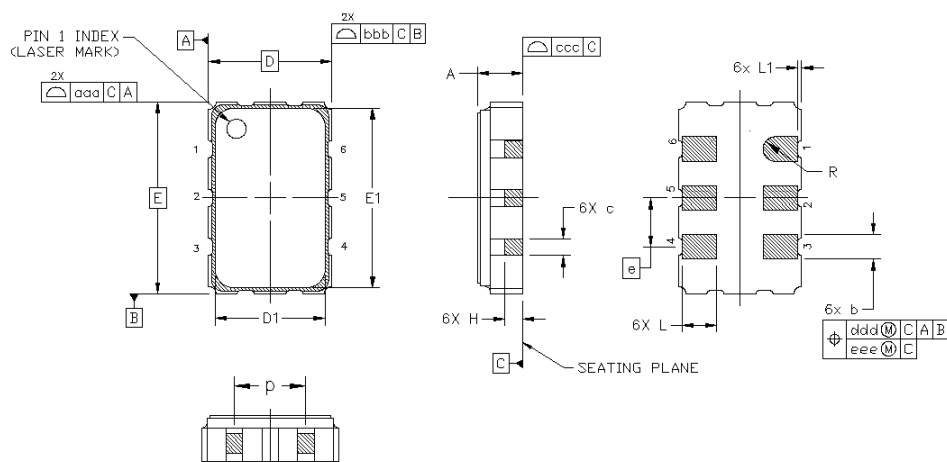


Figure 5.2. Si566 (3.2×5 mm) Outline Diagram

Table 5.2. Package Diagram Dimensions (mm)

| Dimension | Min | Nom | Max |
|-----------|----------|------|------|
| A | 1.06 | 1.17 | 1.33 |
| b | 0.54 | 0.64 | 0.74 |
| c | 0.35 | 0.45 | 0.55 |
| D | 3.20 BSC | | |
| D1 | 2.55 | 2.60 | 2.65 |
| e | 1.27 BSC | | |
| E | 5.00 BSC | | |
| E1 | 4.35 | 4.40 | 4.45 |
| H | 0.45 | 0.55 | 0.65 |
| L | 0.80 | 0.90 | 1.00 |
| L1 | 0.05 | 0.10 | 0.15 |
| p | 1.36 | 1.46 | 1.56 |
| R | 0.32 REF | | |
| aaa | 0.15 | | |
| bbb | 0.15 | | |
| ccc | 0.08 | | |
| ddd | 0.10 | | |
| eee | 0.05 | | |

Notes:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

6. PCB Land Pattern

6.1 PCB Land Pattern (5×7 mm)

The figure below illustrates the 5×7 mm PCB land pattern for the Si566. The table below lists the values for the dimensions shown in the illustration.

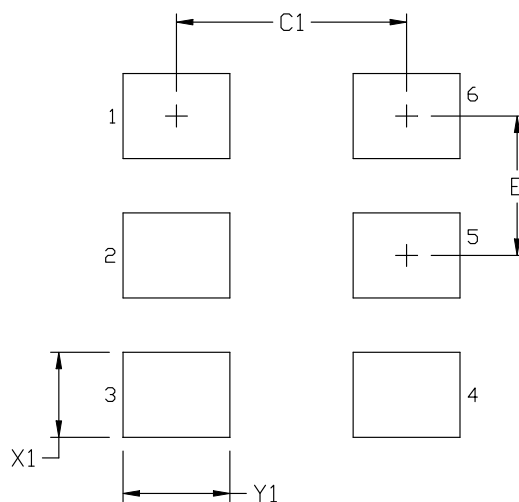


Figure 6.1. Si566 (5×7 mm) PCB Land Pattern

Table 6.1. PCB Land Pattern Dimensions (mm)

| Dimension | (mm) |
|-----------|------|
| C1 | 4.20 |
| E | 2.54 |
| X1 | 1.55 |
| Y1 | 1.95 |

Notes:

General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 μm minimum, all the way around the pad.

Stencil Design

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125 mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

6.2 PCB Land Pattern (3.2×5 mm)

The figure below illustrates the 3.2×5.0 mm PCB land pattern for the Si566. The table below lists the values for the dimensions shown in the illustration.

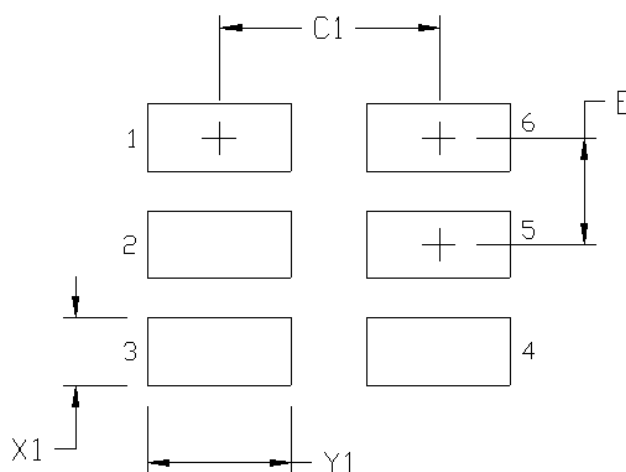


Figure 6.2. Si566 (3.2×5 mm) PCB Land Pattern

Table 6.2. PCB Land Pattern Dimensions (mm)

| Dimension | (mm) |
|-----------|------|
| C1 | 2.60 |
| E | 1.27 |
| X1 | 0.80 |
| Y1 | 1.70 |

Notes:

General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 μ m minimum, all the way around the pad.

Stencil Design

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125 mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

7. Top Marking

The figure below illustrates the mark specification for the Si566. The table below lists the line information.

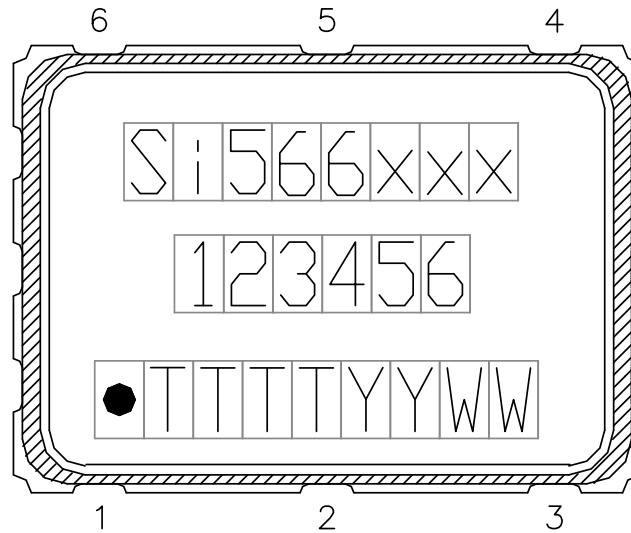


Figure 7.1. Mark Specification

Table 7.1. Si566 Top Mark Description

| Line | Position | Description |
|------|-------------------|---|
| 1 | 1–8 | "Si566", xxx = Ordering Option 1, Option 2, Option 3 (e.g. Si566AAA) |
| 2 | 1–6 | Frequency Code (6-digit custom code as described in the Ordering Guide) |
| 3 | Trace Code | |
| | Position 1 | Pin 1 orientation mark (dot) |
| | Position 2 | Product Revision (B) |
| | Position 3–5 | Tiny Trace Code (3 alphanumeric characters per assembly release instructions) |
| | Position 6–7 | Year (last two digits of the year), to be assigned by assembly site (ex: 2017 = 17) |
| | Position 8–9 | Calendar Work Week number (1–53), to be assigned by assembly site |

8. Revision History

Revision 1.0

June, 2018

- Initial draft



ClockBuilder Pro

One-click access to Timing tools, documentation, software, source code libraries & more. Available for Windows and iOS (CBGo only).

www.silabs.com/CBPro



Timing Portfolio
www.silabs.com/timing



SW/HW
www.silabs.com/CBPro



Quality
www.silabs.com/quality



Support and Community
community.silabs.com

Disclaimer

Silicon Labs intends to provide customers with the latest, accurate, and in-depth documentation of all peripherals and modules available for system and software implementers using or intending to use the Silicon Labs products. Characterization data, available modules and peripherals, memory sizes and memory addresses refer to each specific device, and "Typical" parameters provided can and do vary in different applications. Application examples described herein are for illustrative purposes only. Silicon Labs reserves the right to make changes without further notice and limitation to product information, specifications, and descriptions herein, and does not give warranties as to the accuracy or completeness of the included information. Silicon Labs shall have no liability for the consequences of use of the information supplied herein. This document does not imply or express copyright licenses granted hereunder to design or fabricate any integrated circuits. The products are not designed or authorized to be used within any Life Support System without the specific written consent of Silicon Labs. A "Life Support System" is any product or system intended to support or sustain life and/or health, which, if it fails, can be reasonably expected to result in significant personal injury or death. Silicon Labs products are not designed or authorized for military applications. Silicon Labs products shall under no circumstances be used in weapons of mass destruction including (but not limited to) nuclear, biological or chemical weapons, or missiles capable of delivering such weapons.

Trademark Information

Silicon Laboratories Inc.®, Silicon Laboratories®, Silicon Labs®, SiLabs® and the Silicon Labs logo®, Bluegiga®, Bluegiga Logo®, Clockbuilder®, CMEMS®, DSPLL®, EFM®, EFM32®, EFR, Ember®, Energy Micro, Energy Micro logo and combinations thereof, "the world's most energy friendly microcontrollers", Ember®, EZLink®, EZRadio®, EZRadioPRO®, Gecko®, ISOModem®, Micrium, Precision32®, ProSLIC®, Simplicity Studio®, SiPHY®, Telegesis, the Telegesis Logo®, USBXpress®, Zentri, Z-Wave, and others are trademarks or registered trademarks of Silicon Labs. ARM, CORTEX, Cortex-M3 and THUMB are trademarks or registered trademarks of ARM Holdings. Keil is a registered trademark of ARM Limited. All other products or brand names mentioned herein are trademarks of their respective holders.



Silicon Laboratories Inc.
400 West Cesar Chavez
Austin, TX 78701
USA

<http://www.silabs.com>



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.